

Notice of References Cited	Application/Control No. 10/716,539	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Filip Zec	Art Unit 3744	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,396,776	03-1995	Kim, Jong-Youb	62/115
	B	US-5,605,058	02-1997	Kurachi et al.	62/503
	C	US-5,551,255	09-1996	Rothfleisch, Peter I.	62/502
	D	US-5,966,952	10-1999	Misawa et al.	62/159
	E	US-6,519,971	02-2003	Kim, Cheol Min	62/503
	F	US-6,449,980	09-2002	Minister, David John	62/513
	G	US-5,404,730	04-1995	Westermeyer, Gary W.	62/470
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2-154957	06-1990	Japan	Ko, Naoki	62/503
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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